SDAS078B - DECEMBER 1983 - REVISED JANUARY 1995

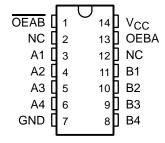
- Two-Way Asynchronous Communication Between Data Buses
- pnp Inputs Reduce dc Loading
- Package Options Include Plastic Small-Outline (D) Packages and Standard Plastic (N) 300-mil DIPs

description

This quadruple bus transceiver is designed for two-way asynchronous communication between data buses.

The SN74ALS758 is characterized for operation from 0°C to 70°C.

D OR N PACKAGE (TOP VIEW)

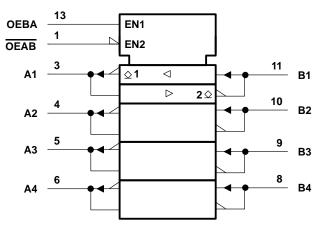


NC - No internal connection

FUNCTION TABLE

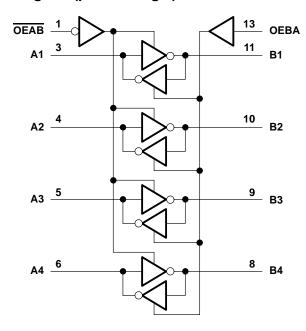
INPUTS		FUNCTION	
OEAB	OEBA	FUNCTION	
L	L	A to B	
Н	Н	B to A	
Н	L	Isolation	
L	Н	Latch A and B $(A = \overline{B})$	

logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC}	7 \
Input voltage, V _I : All inputs and I/O ports	7 \
Operating free-air temperature range, T _A	0°C to 70°C
Storage temperature range	-65°C to 150°C

recommended operating conditions

		MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
V _{IL}	Low-level input voltage			0.8	V
Vон	High-level output voltage			5.5	V
l _{OL}	Low-level output current			24	mA
TA	Operating free-air temperature	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER TEST CONDITIONS		MIN TYP‡	MAX	UNIT	
٧ıK		$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$		-1.2	V
loh		$V_{CC} = 4.5 \text{ V},$	V _{OH} = 5.5 V		0.1	mA
VOL		V _{CC} = 4.5 V	I _{OL} = 12 mA	0.25	0.4	V
			$I_{OL} = 24 \text{ mA}$	0.35	0.5	
Ч	Control inputs	V _{CC} = 5.5 V	V _I = 7 V		0.1	mA
	A or B ports		V _I = 5.5 V		0.1	
ΊΗ	Control inputs	V _{CC} = 5.5 V,	VI. 27//		20	^
	A or B ports§		V _I =27.7' v		20	μΑ
lII_	Control inputs	V _{CC} = 5.5 V,	V. Adv.		-0.1	A
	A or B ports§		V _I ='0'.'4' v		-0.1	mA
Icc		V _{CC} = 5.5 V	Outputs high	6	10	m /\
			Outputs low	10	16	mA

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

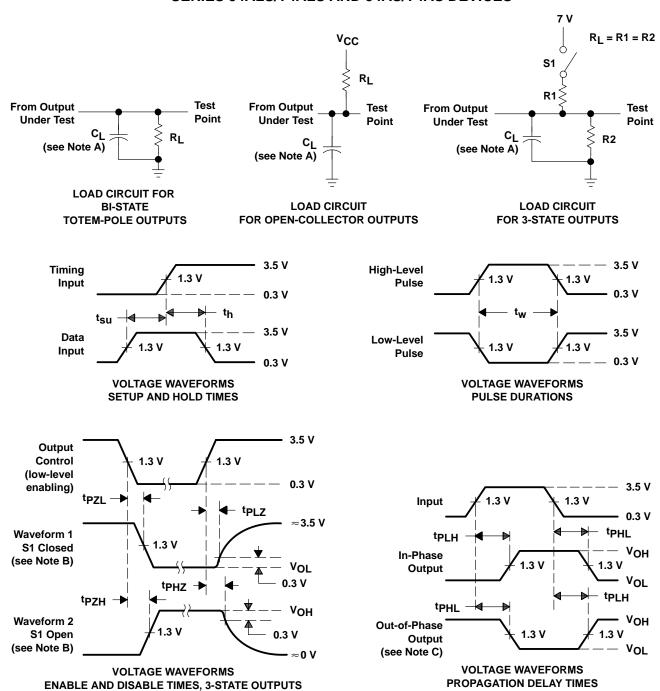
 $[\]mbox{\$ For I/O ports, the parameters I_{IH}}$ and \mbox{I}_{IL} include the off-state output current.

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 4.5 C _L = 50 pF R _L = 680 Ω T _A = MIN to	V to 5.5 V, , , o MAX†	UNIT
			MIN	MAX	
t _{PLH}	A or B	D A	10	28	ns
^t PHL		B or A	2	12	115
^t PLH	OEBA		10	28	
^t PHL		A	6	21	ns
^t PLH	OEAB	В	10	28	
^t PHL	OLAB	Ь	6	21	ns

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



- NOTES: A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
 - All input pulses have the following characteristics: PRR \leq 1 MHz, $t_{\Gamma} = t_{f} = 2$ ns, duty cycle = 50%.
 - The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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